

Search Notes

Application/Control No.

10/033,031

Examiner

Michael Chuen

Applicant(s)/Patent under
Reexamination

INOUE, RUMIKO

Art Unit

2661

SEARCHED

Class	Subclass	Date	Examiner
370	352-356, 401	9/21/2005	MPC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
370/352-356, 401 (text search only - see search history printout)	9/21/2005	MPC